## Notice of References Cited Application/Control No. 10/723,160 Examiner FARHAN M. SYED Applicant(s)/Patent Under Reexamination MILLER ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0085560 A1	07-2002	Cathey et al.	370/392
*	В	US-2003/0005146 A1	01-2003	Miller et al.	709/238
*	С	US-6,651,096 B1	11-2003	Gai et al.	709/223
*	D	US-2004/0078683 A1	04-2004	Buia et al.	714/037
*	Е	US-2004/0260818 A1	12-2004	Valois et al.	709/229
*	F	US-2005/0114655 A1	05-2005	Miller et al.	713/163
*	G	US-6,996,662 B2	02-2006	Miller et al.	711/108
*	Ι	US-7,075,926 B2	07-2006	Cathey et al.	370/389
*	ı	US-7,149,216 B1	12-2006	Cheriton, David R.	370/392
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.